

Notice of References Cited

Application/Control No.

09/814,050

Applicant(s)/Patent Under
Reexamination
OHKI ET AL.

Examiner

Jennifer T Nguyen

Art Unit

2674

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,014,141	01-2000	Klein, Dean A.	345/835
	B	US-6,466,202	10-2002	Suso et al.	345/169
	C	US-5,841,849	11-1998	Macor, James Joseph	379/142.17
	D	US-6,456,841	09-2002	Tomimori, Takeshi	455/412.2
	E	US-6,069,648	05-2000	Suso et al.	348/14.02
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	09-026832	01-1997	Japan	Kitazawa et al.	G06F 1/16
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.